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SERIAL NUMBER 10/688,630	FILING DATE 10/17/2003 RULE	CLASS 073	GROUP ART UNIT 2856	ATTORNEY DOCKET NO. YOR920030276US1 (8728-633)	
APPLICANTS Daniel Worledge, Poughquag, NY; ** CONTINUING DATA <i>NONE</i> <i>PR</i> ** FOREIGN APPLICATIONS <i>NONE</i> <i>PR</i> IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 01/24/2004					
Foreign Priority claimed <input type="checkbox"/> yes <input checked="" type="checkbox"/> no 35 USC 119 (a-d) conditions met <input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after Allowance Verified and Acknowledged	Examiner's Signature <i>ED</i> Initials	STATE OR COUNTRY NY	SHEETS DRAWING 1	TOTAL CLAIMS 17	INDEPENDENT CLAIMS 2
ADDRESS Frank Chau, Esq. F. CHAU & ASSOCIATES, LLP Suite 501 1900 Hempstead Turnpike East Meadow, NY 11554					
TITLE Atomic force microscope and method for determining properties of a sample surface using an atomic force microscope					
FILING FEE RECEIVED 770	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____		

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